Phonon lifetimes in silicon from 50 GHz to 15 THz

David Cahill, Yuxin Wang, Kwangu Kang, Fumiya Watanabe, Yee Kan Koh, and Jeffrey Letcher

Department of Materials Science and Engineering and Materials Research Laboratory,
University of Illinois, Urbana, IL

Brian Daly

Vassar College, Poughkeepsie, NY









Experimental studies of silicon phonon lifetimes at room temperature



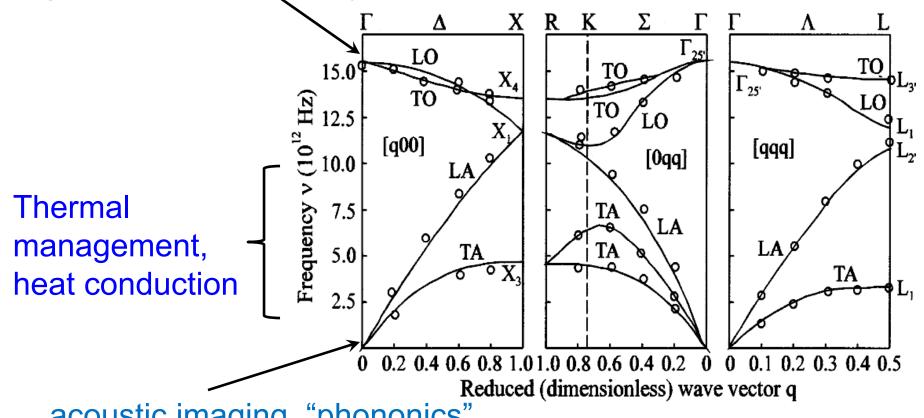
- Attenuation of 50-100 GHz longitudinal acoustic phonons measured by picosecond acoustics.
 - PRB **80**, 174112 (2009).
- Thermal acoustic phonons (1-10 THz) and reduction of thermal conductivity by mass disorder.
 - PRB **71**, 235202 (2005); JAP **104**, 024905 (2008).
- Lifetimes of 15 THz optical phonons by timeresolved incoherent anti-Stokes Raman scattering.
 - APL **90**, 252104 (2007).



Si phonon dispersion



high-field carrier mobility, hot carrier photovoltaics



acoustic imaging, "phononics"

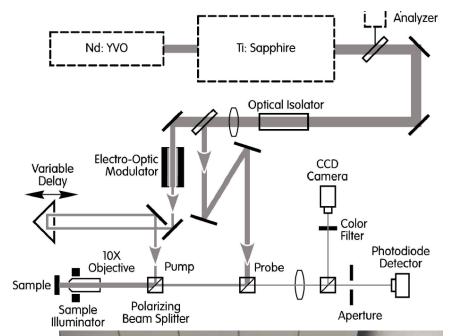


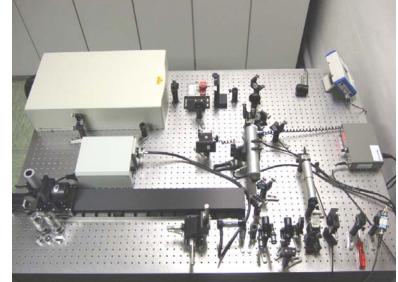
Time domain thermoreflectance and picosecond acoustics



- Improved optical design
- Normalization by out-of-phase signal eliminates artifacts, increases dynamic range and improves sensitivity
- Exact analytical model for Gaussian beams and arbitrary layered geometries
- One-laser/two-color approach tolerates diffuse scattering

Clone built at Fraunhofer Institute for Physical Measurement, Jan. 7-8 2008



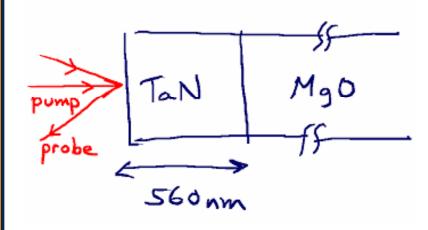


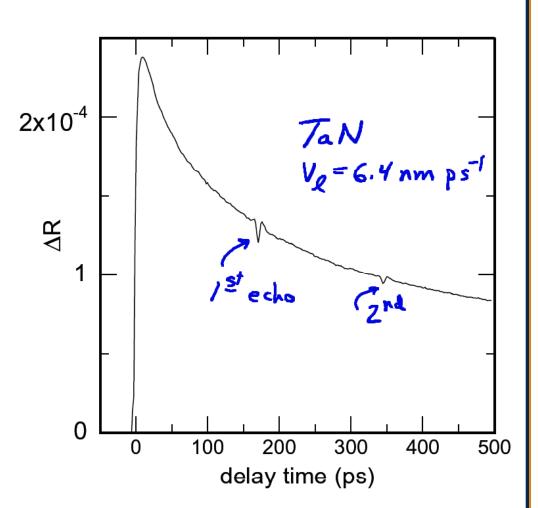


Time domain thermoreflectance and picosecond acoustics



- Optical constants and reflectivity depend on strain and temperature
- Strain echoes give acoustic properties or film thickness
- Thermoreflectance gives thermal properties



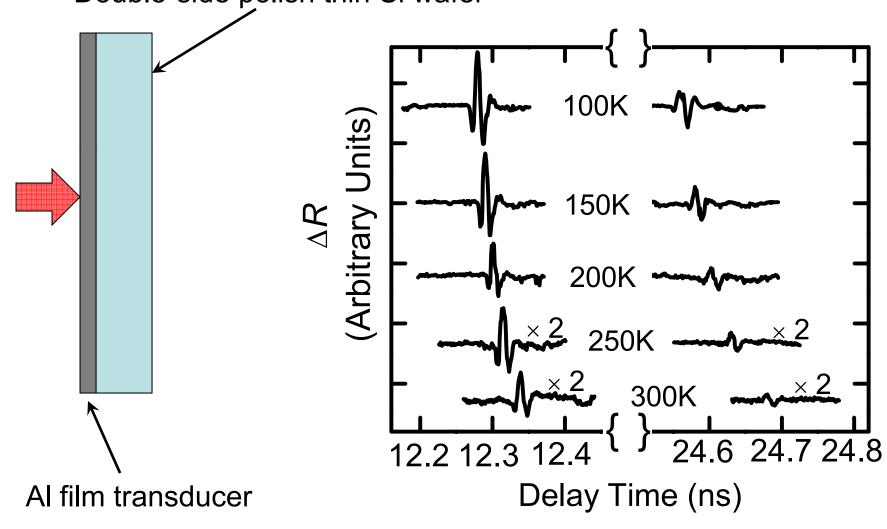




One and two round trips in 50 µm Si wafer





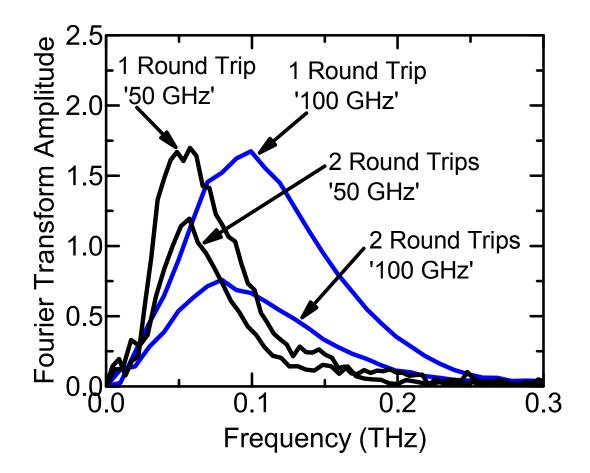




Broadband acoustic pulses



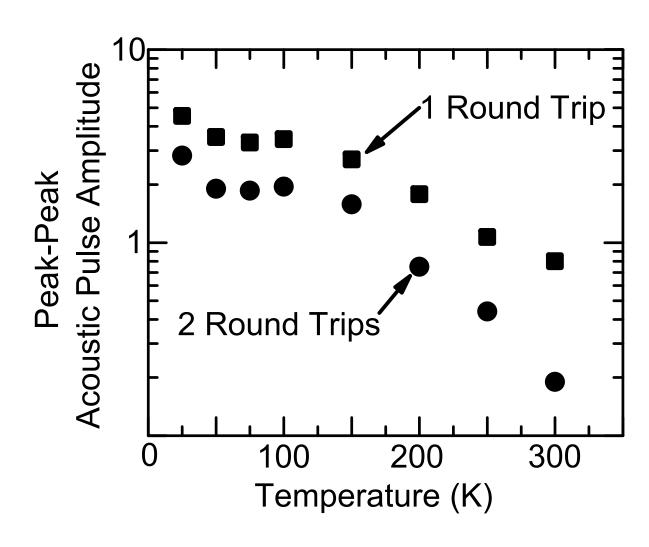
 Fourier transforms of echoes from 10 nm (100 GHz) and 20 nm (50 GHz) Al films





Analyze temperature dependence to eliminate surface effects



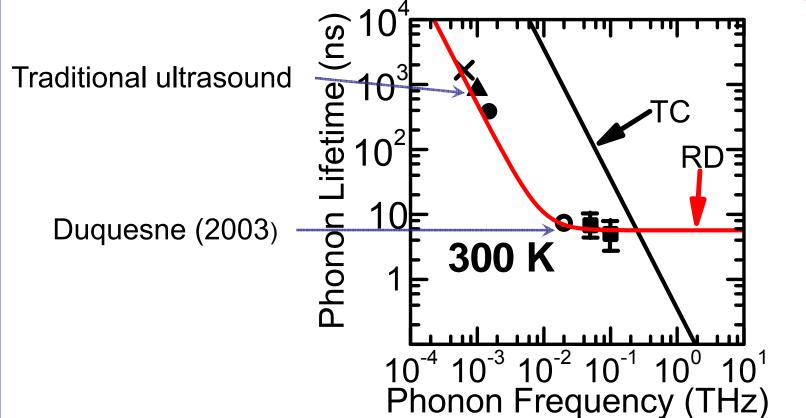




f<100 GHz phonons decay by Akhieser mechanism



- TC=prediction from thermal conductivity measurements, based on three-phonon scattering and truncated Debye model
- RD=relaxational decay (Akhieser mechanism): strain wave distorts thermal phonon population with relaxation time $\tau = 17~\mathrm{ps}$

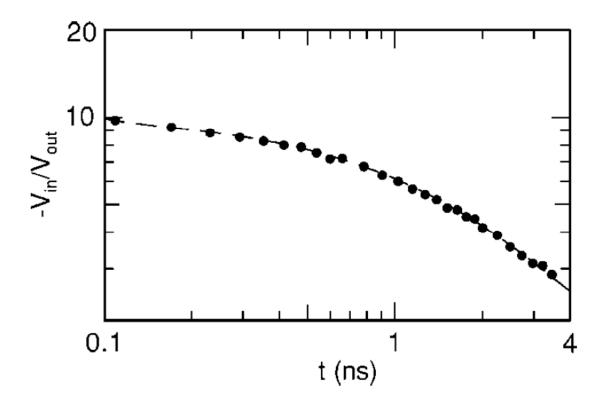




TDTR enables measurements of epitaxial layers of high thermal conductivity



- Time-domain thermoreflectance (TDTR) data and model fit for isotopically pure ²⁸Si
 - Two free parameters: thermal conductivity: Λ=164
 W/m-K; interface conductance G=185 W/m²-K

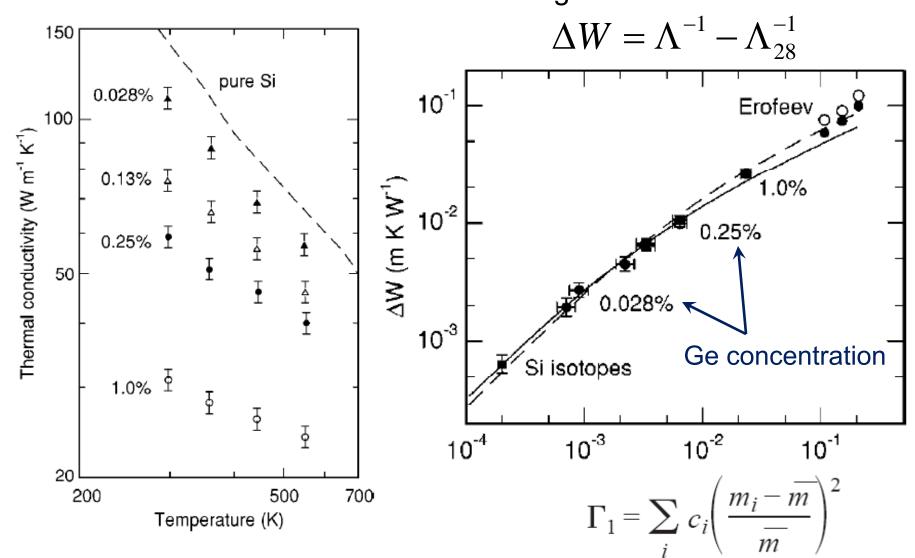




Dilute SiGe alloys grown by gas-source molecular beam epitaxy



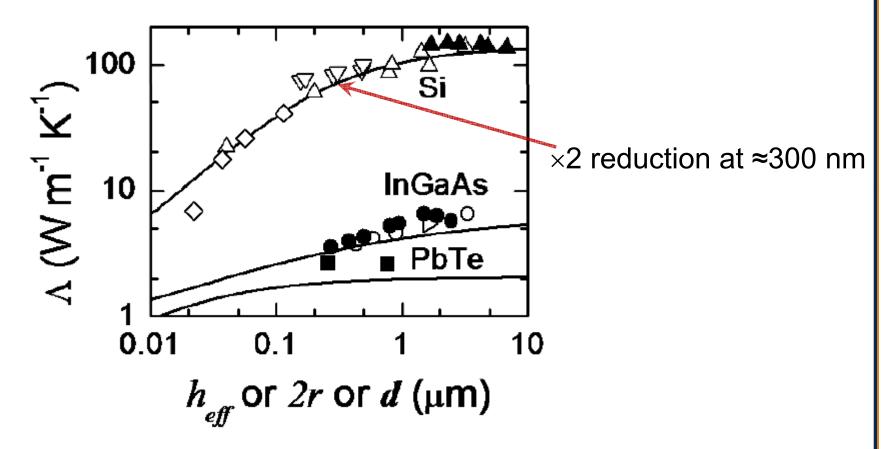
Change in thermal resistance





Same truncated Debye-Callaway model predicts boundary scattering





Si thin films: Ju & Goodson; Asheghi et al; Liu & Asheghi

Si nanowires: Li et al., APL, 2003

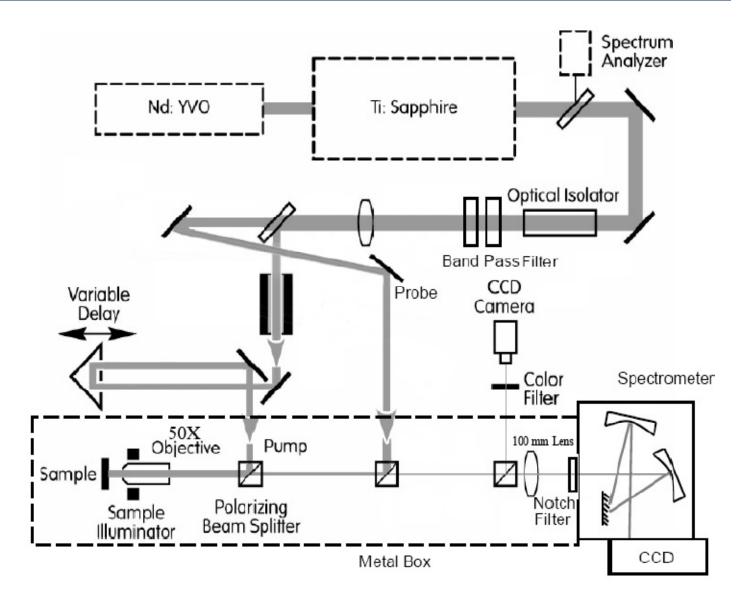
InGaAs thin films: Koh & Cahill, PRB, 2007

PbTe: Koh et al., in preparation



Pump-probe Raman spectrometer

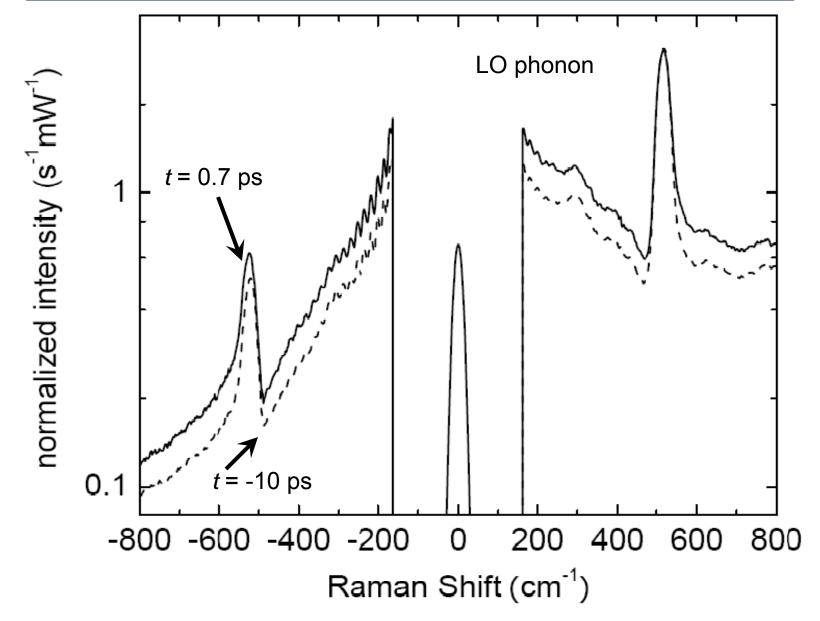






Time-resolved Raman spectra

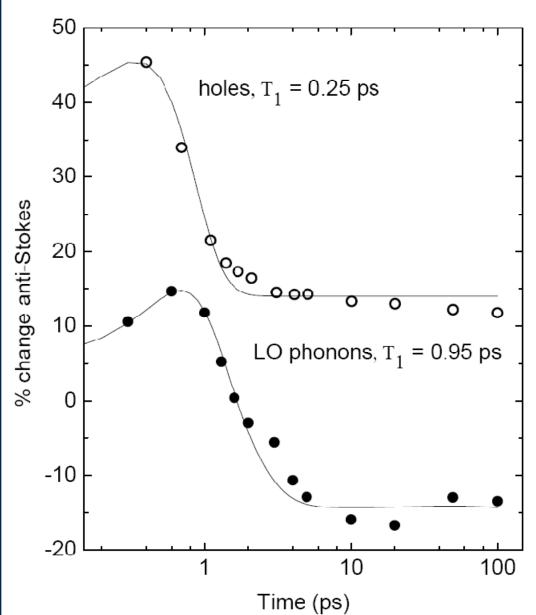






Time-resolved anti-Stokes intensities



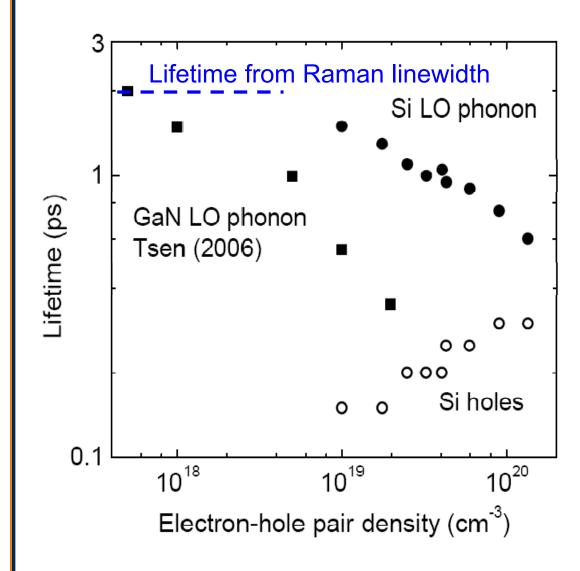


- ➤ Integral of intensity in range 600-650 anti-Stokes wavenumbers gives electronic scattering by interband hole excitations.
- Integral (after background subtraction) of 490-550 cm⁻¹ gives intensity of LO phonon scattering
- > Pump power: 86 mW



Lifetime depends on photoexcited carrier density





- At low excitation, lifetime approaches prediction from Raman linewidth: pure-dephasing is not important.
- Lifetime of zone center phonons decreases at higher excitation. Spectral diffusion? Enhanced coupling to acoustic modes?



Summary



- Lifetime of 100 GHz longitudinal phonons is ~5 nsec; fit to Akhieser mechansims gives thermal phonon lifetime of ~20 ps assuming $\langle \gamma^2 \rangle \langle \gamma \rangle^2 = 1$
- Model fits to thermal conductivity of isotopically pure Si and dilute SiGe alloys is consistent with dominant mean-free-path for heat carrying phonons of 300 nm. Lifetime ~30 ps.
- Lifetime of zone-center optical phonon is 2 ps but depends on carrier (hole) density.